

INTERNATIONAL STANDARD



Optical amplifiers – Test methods – Part 1-1: Power and gain parameters – Optical spectrum analyzer method



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IEC 61290-1-1

Edition 4.0 2020-09
REDLINE VERSION

INTERNATIONAL STANDARD



Optical amplifiers – Test methods – Part 1-1: Power and gain parameters – Optical spectrum analyzer method

INTERNATIONAL
ELECTROTECHNICAL
COMMISSION

ICS 33.180.30

ISBN 978-2-8322-8855-9

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CONTENTS

| | |
|---|----|
| FOREWORD | 3 |
| 1 Scope | 5 |
| 2 Normative references | 5 |
| 3 Terms, definitions, and abbreviated terms | 6 |
| 3.1 Terms and definitions | 6 |
| 3.2 Abbreviated terms | 6 |
| 4 Apparatus | 6 |
| 4.1 Test setup | 6 |
| 4.2 Characteristics of test equipment | 9 |
| 5 Test sample | 11 |
| 6 Procedure | 11 |
| 6.1 Gain and nominal output signal power | 11 |
| 6.2 PDG variation | 12 |
| 6.3 Maximum output signal power | 12 |
| 6.4 Maximum total output power | 12 |
| 6.5 Gain ripple | 13 |
| 6.5.1 General | 13 |
| 6.5.2 Method 1 – Signal gain method | 13 |
| 6.5.3 Method 2 – ASE method | 14 |
| 6.6 Detail requirements of apparatus | 14 |
| 7 Calculation | 14 |
| 7.1 Nominal output signal power | 14 |
| 7.2 Gain | 14 |
| 7.3 Polarization-dependent gain | 15 |
| 7.4 Maximum output signal power | 15 |
| 7.5 Maximum total output power | 15 |
| 7.6 Gain ripple | 16 |
| 7.6.1 Method 1 – Signal gain test method | 16 |
| 7.6.2 Method 2 – ASE method | 17 |
| 8 Test results | 18 |
| Bibliography | 20 |

Figure 1 – Typical arrangement of optical spectrum analyzer test apparatus for gain and power measurements 7

Figure 2 – Typical arrangement of optical spectrum analyzer test apparatus for gain ripple measurements 8

Figure 3 – Example of gain ripple spectrum with the signal gain method 17

Figure 4 – Example of gain ripple spectrum with ASE method 18

INTERNATIONAL ELECTROTECHNICAL COMMISSION

OPTICAL AMPLIFIERS – TEST METHODS –

**Part 1-1: Power and gain parameters –
Optical spectrum analyzer method**

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International Standard IEC 61290-1-1 has been prepared by subcommittee 86C: Fibre optic systems and active devices, of IEC technical committee 86: Fibre optics.

This fourth edition cancels and replaces the third edition published in 2015 and constitutes a technical revision.

This edition includes the following significant technical change with respect to the previous edition: addition of techniques to test gain ripple of SOAs.

The text of this International Standard is based on the following documents:

| | |
|---------------|------------------|
| FDIS | Report on voting |
| 86C/1673/FDIS | 86C/1687/RVD |

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

This document is to be used in conjunction with IEC 61290-1 and IEC 61291-1.

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